Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/895,057	JUTZI ET AL.
Examiner	Art Unit
Ellen C. Tran	2134

SEARCHED				
Class	Subclass	Date	Examiner	
713	176	2/11/2007	ECT	
726	27	2/11/2007	ECT	
726	29	2/11/2007	ECT	
713	164	2/11/2007	ECT	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH	TES STRATEGY	)
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	2/11/2007	ECT
NPL - IEEE XPLORE	2/11/2007	ECT
All claims were reviewed for possible 101 rejection	2/11/2007	ECT